Particle size and shape characterization by Dynamic Image Analysis

CAMSIZER X2
Retsch Technology – Optical Particle Measurement at Its Best
Quality „made in Germany“ for research and quality control use

RETSCH Technology is your superior partner for optical particle characterization. We provide our customers with advanced technologies and comprehensive application expertise to obtain consistently reliable results. The measurement principles used in our particle analyzers are laser diffraction and dynamic image analysis which are suitable for the characterization of a variety of different materials. The analyzers cover a size range from 0.3 nm to 30 mm – from nano particles to pebbles!

Our highly specialized team develops and manufactures the image analyzers at the company’s headquarters in Haan near Duesseldorf. Innovation, quality and customer needs are the foundations of our business. We not only provide first-rate measurement technology but also feature comprehensive service, through application support and hands-on training. As part of the Verder Scientific Group we offer worldwide support through a network of subsidiaries and distributors.

PREMIUM QUALITY
MADE IN GERMANY
With the ever increasing demands for product quality, accurate evaluation of raw materials, intermediates and final products has become indispensable. Automation, high sample throughput and short measurement times make the CAMSIZER system an ideal tool for routine analyses and quality control. Sophisticated evaluation software provides a wealth of valuable information as well as measurement parameters. Hence the analyzers are frequently employed in research and development applications also.

RETSCH Technology has set the standard in dynamic image analysis by inventing the patented dual camera technology implemented in all instruments in the CAMSIZER series. Unmatched accuracy and reproducibility combined with a wide dynamic measuring range place the CAMSIZER series among the most powerful image analyzers in the world. The product family comprises two models optimized for different application areas:

- CAMSIZER X2 for fine, agglomerating powders and suspensions
- CAMSIZER P4 for free-flowing bulk materials and granules

CAMSIZER Series
High-resolution dynamic image analysis of particle size and particle shape
The CAMSIZER X2 is a powerful, extremely versatile particle analyzer with a wide measuring range that combines state-of-the-art camera technology with flexible dispersion options. Based on the principle of Dynamic Image Analysis, the CAMSIZER X2 provides precise particle size and shape information of powders, granules and suspensions in a measuring range from 0.8 µm to 8 mm.

The CAMSIZER X2 produces a particle flow which is characterized by an optical system with high resolution. An ultrabright LED stroboscopic light sources and two high-resolution digital cameras achieve a frame rate of more than 300 images per second which are evaluated in real time by powerful software. Thus, the CAMSIZER X2 captures the images of hundreds of thousands to several million particles with highest accuracy within only 1 to 3 minutes. The CAMSIZER X2 provides a wide selection of particle information which allows for comprehensive and reliable characterization of the sample material. It is suitable for use in R&D as well as for routine tasks in quality control.
Particle Analyzer CAMSIZER X2

- Particle size and particle shape analysis from 0.8 µm to 8 mm with Dynamic Image Analysis (ISO 13322-2)
- Precise analysis of wide size distributions
- Excellent resolution of narrow or multimodal size distributions
- Detection of small amounts of oversized or undersized particles
- Fully comparable to sieve analysis and laser diffraction results
- A wealth of evaluation options (different size models, a variety of shape parameters, particle library, single frame evaluation, etc.)
- Outstanding reproducibility
- Measurement time 1 – 3 minutes, high sample throughput
- Modular „X-Change“ system for dry and wet measurement
- Ultra-strong LEDs and high-resolution cameras for the clearest results
- Easy operation, virtually maintenance-free

PREMIUM QUALITY
MADE IN GERMANY
The dual camera technology invented and patented by RETSCH Technology is a landmark in the development of image analysis technology. By simultaneously employing two cameras with different magnifications, extremely wide dynamic measuring ranges are analyzed. This is accomplished without hardware adjustments or modifications and without compromising accuracy. Each camera is specialized for one measuring range. The ZOOM camera analyzes fine particles with highest precision whereas the BASIC camera detects the larger particles with excellent statistics. A special algorithm combines the information provided by both cameras and delivers the exact size distribution in a possible range of more than three decades!

This arrangement resolves a significant drawback of many image analysis systems that employ only one camera, e.g. microscopes. Such instruments either cannot correctly report the fine particles in wide size distributions, or the large particles are not captured due to the small field of view.

Extremely Wide Measuring Range due to Dual Camera Technology
Two cameras operate simultaneously during measurement: the BASIC camera (red) analyzes the larger particles, the ZOOM camera (blue) captures the small particles. This procedure ensures optimum measurement conditions for all particle sizes in a distribution.

Measurement Principle

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Modular X-Change System for Maximum Flexibility

Correct sample preparation and dispersion of the particles before passing into the measurement field are as important as the actual analysis. Particularly for fine powders which tend to agglomerate, sufficient dispersion is crucial to the reliability of the measurement results. Therefore, various modes of sample feeding help to achieve separation of the agglomerates without destroying individual particles. The CAMSIZER X2 offers three dispersion options:

- **Dispersion by compressed air**
  The X-Jet module disperses the sample via a Venturi nozzle and is suitable for effective analysis of powdered samples. The actual measurement of the particles takes place in the air stream. Dispersion pressure may be set between 5 kPa and 460 kPa. This ensures optimum analysis conditions for all sample types.

- **Dispersion by gravity**
  The X-Fall module is used for non-destructive measurement of sensitive samples in free fall to minimize particle breakage. The sample can be recovered after the analysis.

- **Dispersion in liquids**
  CAMSIZER X2 also offers the option to analyze particles in liquids with the X-Flow module. The suspension flows in a closed circle through a glass cell where the cameras record the particle images. The integrated ultrasonic unit further aids in the dispersion process.
Modular Design for Maximum Flexibility

The dispersion of the particles before they pass the measurement field, is an essential prerequisite for many desired analysis results.

The CAMSIZER X2’s modular “X-Change” system offers three alternative dispersion methods, permitting the selection of the optimum method for each sample type. The user may choose between wet dispersion with X-Flow or dry measurement either in free fall with X-Fall or in an air flow with X-Jet. The modules and cartridges are quickly and easily exchanged which makes working with the CAMSIZER X2 convenient and safe.

Air Pressure Dispersion with X-Jet

Many materials tend to agglomerate due to surface forces. The X-Jet module effectively disperses the particles in an air flow while passing through a Venturi nozzle. The dispersion pressure can be set as required for individual particles. For sensitive granules, for example, reduced pressure ensures non-destructive measurement. After passing the measurement field, the sample is automatically removed from the analyzer by a vacuum cleaner.

- Pressure adjustable from 5 kPa to 450 kPa
- Effective dispersion, also for particles < 10 µm
- Gentle measurement of friable samples
- Quick analysis of large quantities
- Different nozzle diameters available for the control of dispersion energy
Wet Measurement with X-Flow

The wet module X-Flow analyzes suspensions in a size range from 0.8 µm to 1 mm. The sample moves within a closed loop from the dispersion bath to the flow cell where the camera system captures the particle images. X-Flow comes with an ultrasonic bath and strong centrifugal pump to ensure efficient dispersion. Suitable dispersion media are water, alcohol, and also nonpolar organic solvents.

- Analysis of suspensions
- Effective dispersion with ultrasound
- Resistant to organic solvents
- Various cells available

Gravity Dispersion with X-Fall

Flowable, unagglomerated samples can be analyzed by using the “X-Fall” module. Agglomerated samples which need to be analyzed in this form can be analyzed similarly. The measurement is non-destructive because the particles directly fall from a chute through the field of view. X-Fall is suitable for particle sizes up to 8 mm; the detection sensitivity for over-sized grains is extremely high. In contrast to dispersion by air pressure, the sample can be recovered after the measurement with X-Fall.

- Gentle, contact-free measurement
- Analysis of particle sizes up to 8 mm
- Complete sample recovery
A Wealth of Analysis and Evaluation Options

All parameters at a glance: Dynamic image analysis provides comprehensive information about the sample material to be analyzed. The high-performance CAMSIZER software measures dozens of parameters from every single particle and presents the results in a clearly structured, standard-compliant measurement report. Functions like the comprehensive export option and the generation of synoptical tables or trend analyses are routine procedures.

Storage and automatic monitoring of predetermined product specifications are also part of the software. Password protection prevents undesired modifications of measurement settings. Hence, analyses may also be carried out by non-technical staff.

Detailed Evaluations with Particle X-Plorer

The strength of Dynamic Image Analysis is the evaluation of a vast number of particles in a very short period of time. The result after 2 to 3 minutes measuring time is usually based on hundreds of thousands to millions of single particles which guarantees a high statistical reliability. Moreover, the innovative software module Particle X-Plorer imports information on individual particles into a database, thus allowing the user to find particles with specific characteristics or combinations of characteristics. This facilitates application development, interpretation of measurement results and understanding of the sample material. Further options provided by Particle X-Plorer include the creation of 3D scatter diagrams or subsequent filtering and advanced evaluation of complete data sets.
Only Image Analysis Provides Information on Particle Shape

Bulk material properties like density, flowability, compactibility, conveying characteristics and surface condition are influenced by particle shape. This makes these parameters a crucial process and quality indicator in many application areas.

Examples:
- Angularity of abrasives
- Analysis of broken fractions in granules
- Detection of agglomerates in glass beads
- Analysis of the roundness of plastic or metal powder particles for Additive Manufacturing (direct influence on flowability and packing density)
- Length and diameter of needle-shaped crystals
- Analysis of the roundness of sand particles to evaluate the usability as construction/support material or for geological examinations

Various parameters are available for shape quantification (see illustration on the left). These include width/length ratio (aspect ratio), circularity (calculated from area-to-perimeter ratio), symmetry, convexity, and compactness. Roundness is calculated from the curvature of the particles’ edges.
"Size" is only defined unambiguously for spherical particles: the diameter is identical in all directions and orientations. For non-spherical particles, however, the dimensions can vary strongly, depending on the orientation and direction of measurement. Traditional sieve analysis, for example, separates particles on a wire mesh sieve stack with different aperture sizes into fractions.

The smallest possible sieve aperture that a particle can pass is defined by the particle’s smallest projection area. Hence, sieve analysis measures particles in a preferential orientation and provides information which is mostly based on the width of the particle. Particle size analysis with laser diffraction relates all measuring data to the diameter of a spherical particle model. Only image analysis offers different size definitions which can be ascertained simultaneously. This makes the results correctable to those obtained with other techniques.

The outstanding strength of DIA is the possibility to measure width and length of a particle and to provide a size distribution based on these parameters. The particle width (red curve) can easily be compared to sieve analysis results.

DIA may use different size definitions
# Sieve Analysis, Laser Diffraction, Static or Dynamic Image Analysis?

A comparison of measurement techniques

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Powder Metallurgy

The different techniques used in powdered metallurgy require different material properties. For Additive Manufacturing (AM), for example selective laser sintering, a homogeneous particle size distribution and spherical particle shape are crucial. The example shows a range of CAMSIZER X2 analyses of various metal powders which are reliably characterized for their suitability to be used in powdered metallurgical processes. Non-spherical, fused or broken particles are reliably detected and quantified. Analysis of metal powders with a mean particle size < 10 µm, which are utilized for Metal Injection Moulding (MIM), is also possible with the CAMSIZER X2.

Coffee powder

Comparability to sieve analysis and laser diffraction

The particle size distribution of coffee powder determines the extraction properties and thus influences the taste. Different types of coffee production (filtered coffee, espresso, etc.) produce different degrees of coarseness. The size distribution of coffee powder may reach up to 1 mm, with a significant fine fraction. The CAMSIZER X2 analyzes this size range quickly and reliably. The CAMSIZER X2 quickly delivers results which are fully comparable to alternative measurement techniques by consideration of the suitable size definition. The results of sieve analysis correspond to the size definition x-c-min. Laser diffraction relates all measuring data to the diameter of an ideal spherical particle. Hence, the results best match the size definition x-area.
Pharmaceuticals & Food
Analysis of granules, active ingredients and additives

The CAMSIZER X2 is ideally suited for particle size and particle shape analysis of a huge variety of pharmaceutical products. A typical application is the analysis of all kinds of pellets and spheres which are quickly and thoroughly measured in dry mode by using the X-Fall or X-Jet module. Thanks to the flexible dispersion options, fine crystalline or micronized active ingredients and additives (like cellulose or citric acid) are easily and efficiently characterized. The software package "AuditTrailManager" is part of the CAMSIZER X2 software and can be made to comply with the requirements of 21CFR part 11. The example shows the results of measuring two granules with similar size but completely different shape.

Minerals & Construction Materials
Reliable detection of oversized grains

The CAMSIZER X2 is suitable for measuring a variety of minerals and ceramic materials. High sample throughput, highest precision and sensitivity to the slightest variations in product quality make the CAMSIZER X2 the ideal instrument for quality control.

For many applications, reliable detection of small amounts of oversized particles is crucial. In this application example, a gypsum sample consisting of particles <100 µm was mixed with a few coarse particles (0.1 wt. %). These are detected by the CAMSIZER X2 with a high degree of accuracy.
Dry Measurement also of Small Particles

The X-Jet plugin cartridge is the perfect choice for measuring fine powders precisely and reproducibly. The example shows a SiC micro-abrasive sample at the lower end of the CAMSIZER X2 measuring range. The size distribution lies between 1 µm and 12 µm. Thanks to the high depth of field, pulsed, ultra-strong light sources and short exposure times, these rapidly moving, micrometer-sized particles are reliably detected. The precisely defined fineness of the abrasive guarantees the optimum combination of abrasion and surface roughness.

Accessories and Options

Optimum configuration for each application

RETSCH Technology offers a variety of hoppers and chutes (1) for special applications. Dispersion nozzles and cuvettes are available in different aperture sizes to ensure optimum conditions for each measurement (2). Calibration of the CAMSIZER X2 only takes one minute and can be carried out by using a high-precision reference Reticle (3). A range of sample dividers produces representative part samples of powders, granulates and all kinds of bulk materials (4).
CAMSIZER X2 at a glance

Technical Data

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The CAMSIZER X2 is CE-certified and complies with the relevant regulations and standards. The vacuum cleaner is included in the delivery of the X-Dry module.

CAMSIZER P4

The CAMSIZER P4 is another powerful particle analyzer by RETSCH Technology which is designed for measuring dry, flowable bulk materials. Just like the X2 model, the CAMSIZER P4 is based on the proven Dual Camera Technology. The P4 model analyzes all samples in free fall (similar to X-Fall); with a measuring range from 20 µm to 30 mm it is particularly suitable for replacing time-consuming and error-prone sieve analyses. Robust hardware and application-oriented software allow for high sample throughput with minimum maintenance and a high degree of automation. The CAMSIZER P4 can be equipped with automated sample feeding for highly efficient process analysis. Für Analyse auf ein Minimum reduziert.

For more information please visit www.retsch.com/camsizerP4